



**ALPHA & OMEGA**  
SEMICONDUCTOR

**AON1606**

**20V N-Channel MOSFET**

### General Description

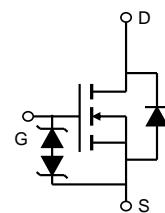
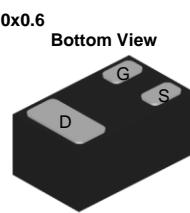
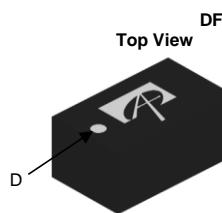
The AON1606 utilize advanced trench MOSFET technology in small DFN 1.0 x 0.6 package. This device is ideal for load switch applications.

### Product Summary

$V_{DS}$	20V
$I_D$ (at $V_{GS}=4.5V$ )	0.7A
$R_{DS(ON)}$ (at $V_{GS}=4.5V$ )	< 275mΩ
$R_{DS(ON)}$ (at $V_{GS}=2.5V$ )	< 335mΩ
$R_{DS(ON)}$ (at $V_{GS}=1.8V$ )	< 390mΩ

Typical ESD protection

HBM Class 1C



### Absolute Maximum Ratings $T_A=25^\circ\text{C}$ unless otherwise noted

Parameter	Symbol	Maximum	Units
Drain-Source Voltage	$V_{DS}$	20	V
Gate-Source Voltage	$V_{GS}$	$\pm 8$	V
Continuous Drain Current <sup>E</sup>	$I_D$	0.7	A
$T_A=70^\circ\text{C}$	$I_D$	0.55	
Pulsed Drain Current <sup>C</sup>	$I_{DM}$	2.8	A
Power Dissipation <sup>A</sup>	$P_D$	0.9	W
$T_A=70^\circ\text{C}$	$P_D$	0.55	
Junction and Storage Temperature Range	$T_J, T_{STG}$	-55 to 150	°C

### Thermal Characteristics

Parameter	Symbol	Typ	Max	Units
Maximum Junction-to-Ambient <sup>A</sup>	$R_{\theta JA}$	80	100	°C/W
Maximum Junction-to-Ambient <sup>A</sup>		110	140	°C/W
Maximum Junction-to-Ambient <sup>B</sup>	$R_{\theta JA}$	200	245	°C/W
Maximum Junction-to-Ambient <sup>B</sup>		280	340	°C/W

**Electrical Characteristics ( $T_J=25^\circ\text{C}$  unless otherwise noted)**

Symbol	Parameter	Conditions	Min	Typ	Max	Units
<b>STATIC PARAMETERS</b>						
$BV_{DSS}$	Drain-Source Breakdown Voltage	$I_D=250\mu\text{A}, V_{GS}=0\text{V}$	20			V
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS}=20\text{V}, V_{GS}=0\text{V}$ $T_J=55^\circ\text{C}$			1 5	$\mu\text{A}$
$I_{GSS}$	Gate-Body leakage current	$V_{DS}=0\text{V}, V_{GS}=\pm 8\text{V}$			$\pm 10$	$\mu\text{A}$
$V_{GS(\text{th})}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=250\mu\text{A}$	0.3	0.65	1.0	V
$I_{D(\text{ON})}$	On state drain current	$V_{GS}=4.5\text{V}, V_{DS}=5\text{V}$	2.8			A
$R_{DS(\text{ON})}$	Static Drain-Source On-Resistance	$V_{GS}=4.5\text{V}, I_D=0.4\text{A}$ $T_J=125^\circ\text{C}$	225	275		$\text{m}\Omega$
		$V_{GS}=2.5\text{V}, I_D=0.3\text{A}$	313	380		$\text{m}\Omega$
		$V_{GS}=1.8\text{V}, I_D=0.2\text{A}$	265	335		$\text{m}\Omega$
		$V_{GS}=1.5\text{V}, I_D=0.1\text{A}$	300	390		$\text{m}\Omega$
$g_{FS}$	Forward Transconductance	$V_{DS}=5\text{V}, I_D=0.4\text{A}$	355			$\text{S}$
$V_{SD}$	Diode Forward Voltage	$I_S=0.4\text{A}, V_{GS}=0\text{V}$	2	0.75	1.2	V
$I_S$	Maximum Body-Diode Continuous Current <sup>E</sup>				-0.7	A
<b>DYNAMIC PARAMETERS</b>						
$C_{iss}$	Input Capacitance	$V_{GS}=0\text{V}, V_{DS}=10\text{V}, f=1\text{MHz}$	62.5			pF
$C_{oss}$	Output Capacitance		12.5			pF
$C_{rss}$	Reverse Transfer Capacitance		9			pF
$R_g$	Gate resistance	$V_{GS}=0\text{V}, V_{DS}=0\text{V}, f=1\text{MHz}$	5.5			$\Omega$
<b>SWITCHING PARAMETERS</b>						
$Q_g$	Total Gate Charge	$V_{GS}=4.5\text{V}, V_{DS}=10\text{V}, I_D=0.4\text{A}$	0.85			nC
$Q_{gs}$	Gate Source Charge		0.1			nC
$Q_{gd}$	Gate Drain Charge		0.25			nC
$t_{D(\text{on})}$	Turn-On Delay Time	$V_{GS}=4.5\text{V}, V_{DS}=10\text{V}, R_L=25\Omega, R_{\text{GEN}}=3\Omega$	2			ns
$t_r$	Turn-On Rise Time		4			ns
$t_{D(\text{off})}$	Turn-Off Delay Time		18			ns
$t_f$	Turn-Off Fall Time		8			ns

A: The value of  $R_{\text{OJA}}$  is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^\circ\text{C}$ . The Power dissipation  $P_{\text{DSM}}$  is based on  $R_{\text{OJA}}$  and the maximum allowed junction temperature of 150° C. The value in any given application depends on the user's specific board design, and the maximum temperature of 150° C may be used if the PCB allows it to.

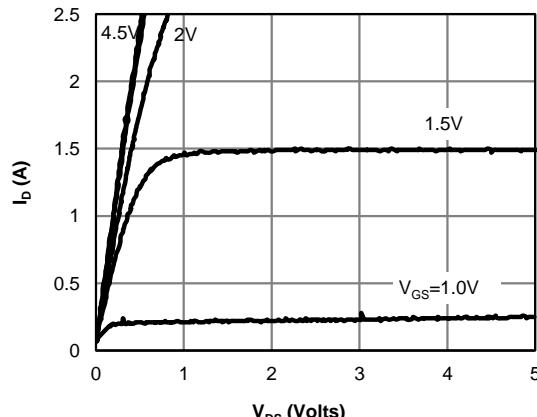
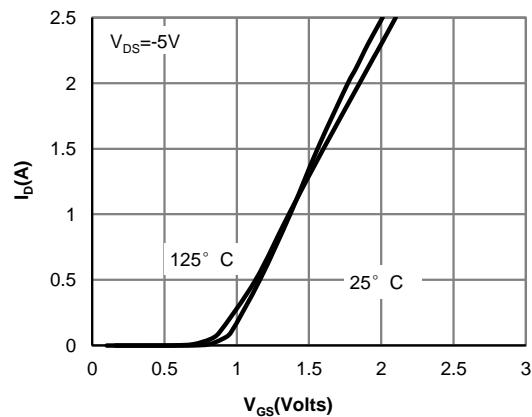
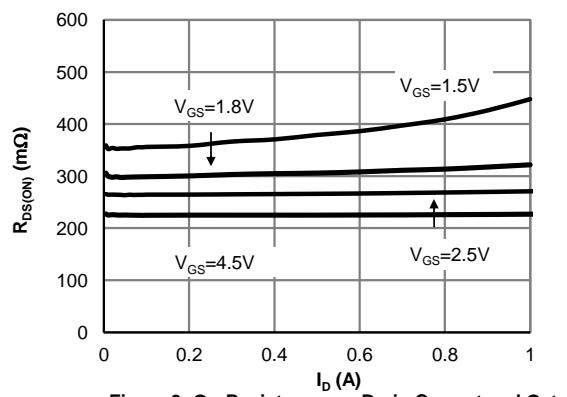
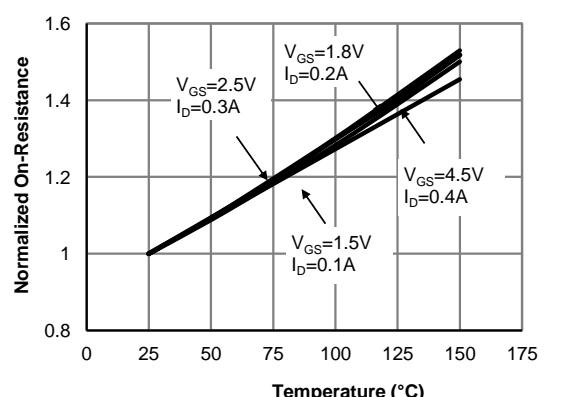
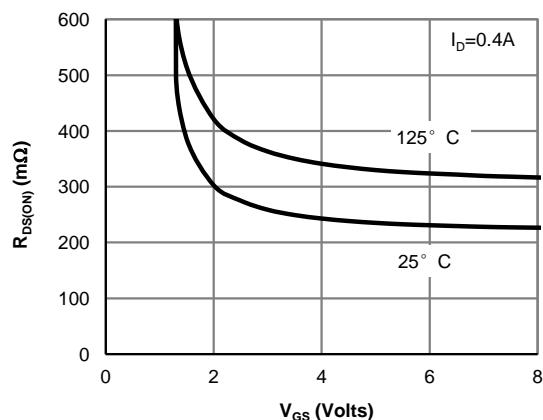
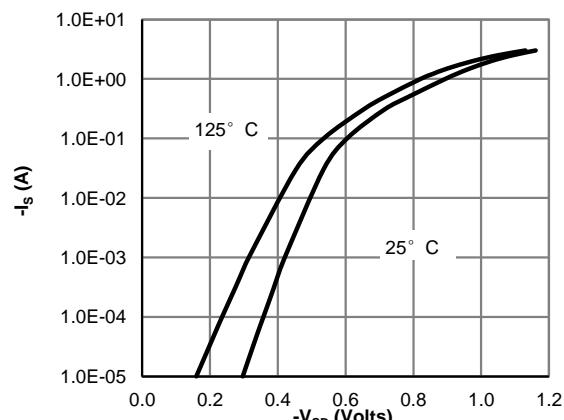
B: The value of  $R_{\text{OJA}}$  is measured with the device mounted on FR-4 minimum pad board, in a still air environment with  $T_A=25^\circ\text{C}$ . The Power dissipation  $P_{\text{DSM}}$  is based on  $R_{\text{OJA}}$  and the maximum allowed junction temperature of 150° C. The value in any given application depends on the user's specific board design, and the maximum temperature of 150° C may be used if the PCB allows it to.

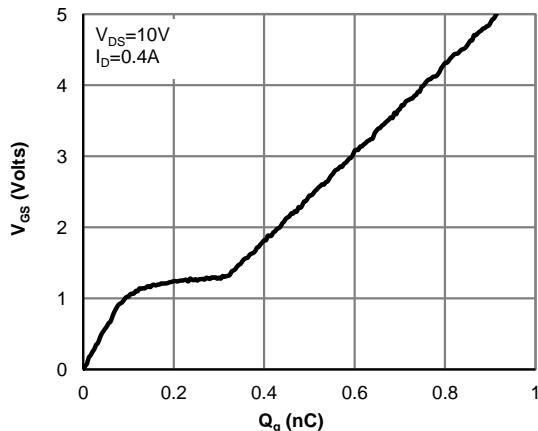
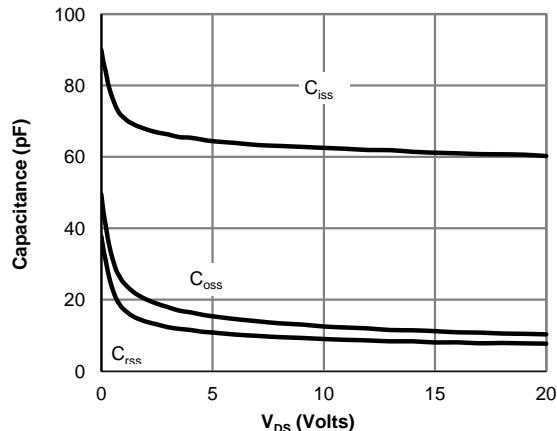
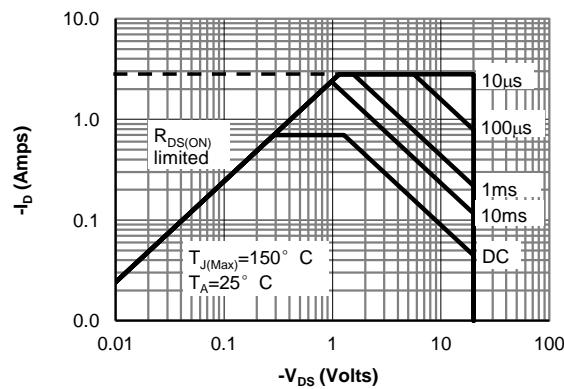
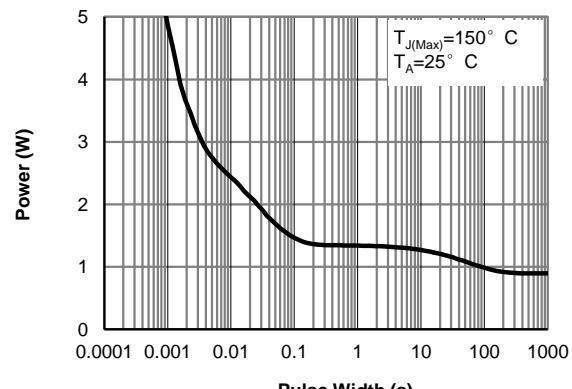
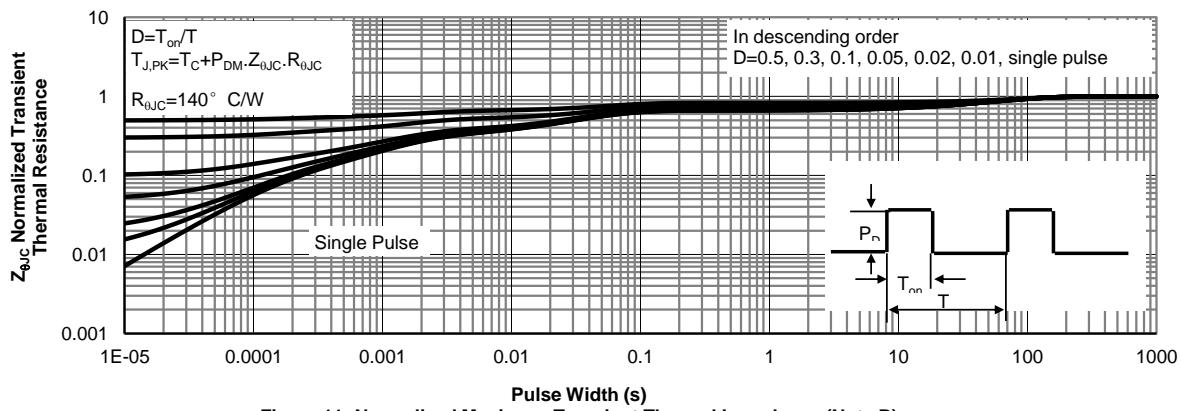
C: The static characteristics in Figures 1 to 6 are obtained using <300  $\mu\text{s}$  pulses, duty cycle 0.5% max.

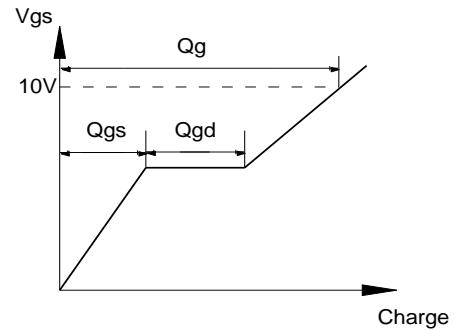
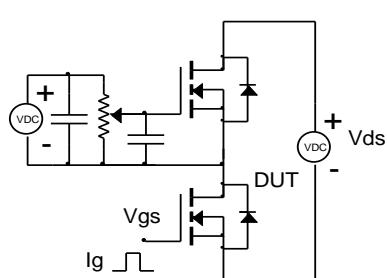
D: These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^\circ\text{C}$ . The SOA curve provides a single pulse rating.

E: The maximum current limited by package.

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**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**

**Fig 1: On-Region Characteristics (Note E)**

**Figure 2: Transfer Characteristics (Note E)**

**Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)**

**Figure 4: On-Resistance vs. Junction Temperature (Note E)**

**Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)**

**Figure 6: Body-Diode Characteristics (Note E)**

**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**

**Figure 7: Gate-Charge Characteristics**

**Figure 8: Capacitance Characteristics**

**Figure 9: Maximum Forward Biased Safe Operating Area (Note B)**

**Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note B)**

**Figure 11: Normalized Maximum Transient Thermal Impedance (Note B)**

**Gate Charge Test Circuit & Waveform**

**Resistive Switching Test Circuit & Waveforms**
